

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/749,532	YAMAKAWA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		T. D. Wessendorf	1639	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0113714 A1	06-2003	Belcher et al.	435/5
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
/	U	Freeman et al, Science, 267, 1995, 1629-1632.□□□□
	V	Puntes et al, Science, 291, 3/2001, 2115-17.
	W	Lee et al, Sience, 296, 5/2002, 892-95
	X	Naik et al, Nature, 2002, 169-172.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.